TOSHIBA Transistor Silicon NPN Triple Diffused Type (Darlington power transistor)

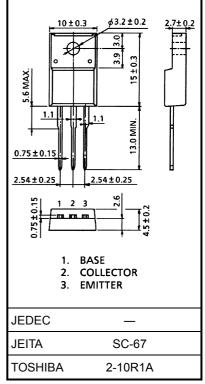
2SD2571

High Power Switching Applications Hammer Drive, Pulse Motor Drive Applications

- High DC current gain: $h_{FE} = 2000 \text{ (min)} (V_{CE} = 2 \text{ V}, I_C = 1 \text{ A})$
- Low saturation voltage: V_{CE} (sat) = 1.5 V (max) (I_C = 1 A)

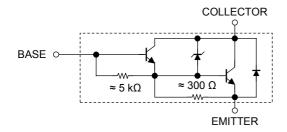
Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Collector-base voltage		V _{CBO}	100 ± 10	V	
Collector-emitter voltage		V _{CEO}	100 ± 10	V	
Emitter-base voltage		V _{EBO}	8	V	
Collector current	DC	Ι _C	2	А	
	Pulse	I _{CP}	3	~	
Base current		Ι _Β	0.5	А	
Collector power dissipation	Ta = 25°C	Pc	2.0	W	
	Tc = 25°C	FC	25		
Junction temperature		Тј	150	°C	
Storage temperature range		T _{stg}	-55 to 150	°C	



Weight: 1.7 g (typ.)

Equivalent Circuit

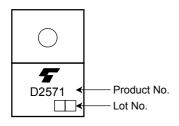


Unit: mm

Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current		I _{CBO}	V _{CB} = 80 V, I _E = 0	_	—	100	μA
Emitter cut-off current		I _{EBO}	V _{EB} = 8 V, I _C = 0	0.8	_	4.0	mA
Collector-emitter breakdown voltage		V (BR) CEO	I _C = 10 mA, I _B = 0	85	100	115	V
DC current gain		h _{FE (1)}	V _{CE} = 2 V, I _C = 1 A	2000	_	15000	
		h _{FE (2)}	V _{CE} = 2 V, I _C = 1.5 A	1000	_	_	
Collector-emitter saturation voltage		V _{CE (sat)}	I _C = 1 A, I _B = 1 mA	_	_	1.5	V
Base-emitter saturation voltage		V _{BE (sat)}	I _C = 1 A, I _B = 1 mA	_	_	2.0	V
Switching time	Turn-on time	t _{on}	$20 \ \mu s$ $Input \rightarrow Input \rightarrow I$	_	0.45	_	
	Storage time	t _{stg}		_	2.0	_	μs
	Fall time	t _f		_	0.4	_	

Marking



Explanation of Lot No.

Month of manufacture (January to December are denoted by letters A to L respectively.)
 Year of manufacture (Last decimal digit of the year of manufacture)

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